

<i>Notice of References Cited</i>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/587,304	KOCH ET AL.	
Examiner		Art Unit		Page 1 of 1
SATYA B. SASTRI		1796		

U. S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-4,128,636	12-1978	Hase et al.	514/772.1
*	B US-6,489,382	12-2002	Giesecke et al.	524/89
*	C US-6,593,408	07-2003	Takaki et al.	524/414
*	D US-2007/0154709	07-2007	Koch et al.	428/379
*	E US-5,853,464	12-1998	Macpherson et al.	106/31.6
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N FR 2345144 A	11-1977	France	GALINKE J et al.	
*	O WO 0155059 A1	08-2001	World Intellect	BENDER R et al.	
*	P WO 0031154 A1	06-2000	World Intellect	LAFUMA F et al.	
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	DE 19923625 A1, Hempelmann et al., Nov. 23, 2000, DERWENT abstract.
V	JP 01183406 A, Hayashi, July 21, 1989, DERWENT abstract.
W	CN 1114634 A, Lei et al., Jan. 10, 1996, DERWENT abstract.
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.